

# IEC 61850 Certificate - IEC 61850 Certificate #2366

## PDCNT-V4 [Hanbit EDS Co., Ltd.]

07/08/2021 04:36 PM - Herbert Falk

<b>Status:</b>	Approved	<b>Test Document:</b>	
<b>Priority:</b>	Normal	<b>Certificate Name:</b>	2013TS02752
<b>61850 Edition:</b>	Edition 1	<b>Certificate Hash:</b>	C2C5D025593C3DAD740C1AF72915F C944CCE56F5F96A84BC1198B8ACF97 DF9C1
<b>61850 Tested Aspects:</b>	Server	<b>Vendor Artifact File Name:</b>	
<b>Company:</b>	Hanbit EDS Co., Ltd.	<b>Vendor Artifact Hash:</b>	
<b>Address:</b>	830 Taplipdong Yuseonggu Daejeon Republic of Korea	<b>Umbrella Organization:</b>	
<b>Product:</b>	PDCNT-V4	<b>Optional Reservation Test:</b>	No
<b>HW Version:</b>	4.1	<b>Serial Number:</b>	
<b>SW Version:</b>	1.50	<b>Publisher Legacy Variants:</b>	
<b>Key Words:</b>		<b>Publisher Preferred Rates:</b>	
<b>Test Procedure Version:</b>	2.3	<b>Publisher Preferred Variants:</b>	
<b>IEC 61850 Blocks Certified:</b>	Basic Exchange (B1), Buffered Reporting (B6), Data Set Definition (B2+), Data Sets (B2), Enhanced SBO Control (12d), Time Synchronization (B13), Unbuffered Reporting (B5)	<b>Subscriber Legacy Variants:</b>	
<b>Certificate/Result Reviewer:</b>	kathy.ellis,bruce.muschlitz	<b>Subscriber Preferred Variants:</b>	
<b>Approval Date:</b>	09/13/2015		
<b>Standards Tested:</b>	61850-6, 61850-7-1, 61850-7-2, 61850-7-3, 61850-7-4, 61850-8-1		
<b>Current Test Lab Name:</b>	Korea Electrotechnology Research Institute (A)		
<b>Description</b>			
This certificate and its information was migrated from a previous database			

### History

#1 - 07/08/2021 04:36 PM - Herbert Falk

- File 2013TS02752\_HanbitEDS\_PDCNT-V4\_KERI.pdf added

### Files

2013TS02752_HanbitEDS_PDCNT-V4_KERI.pdf	1.05 MB	07/08/2021	Herbert Falk
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